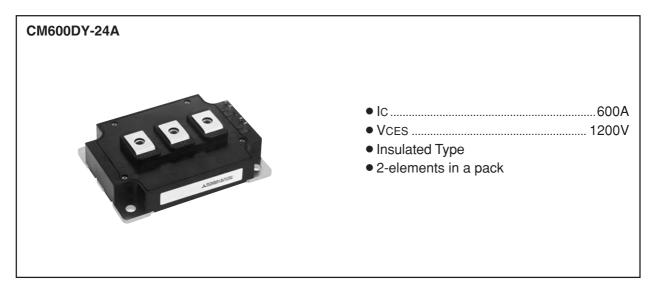
MITSUBISHI IGBT MODULES

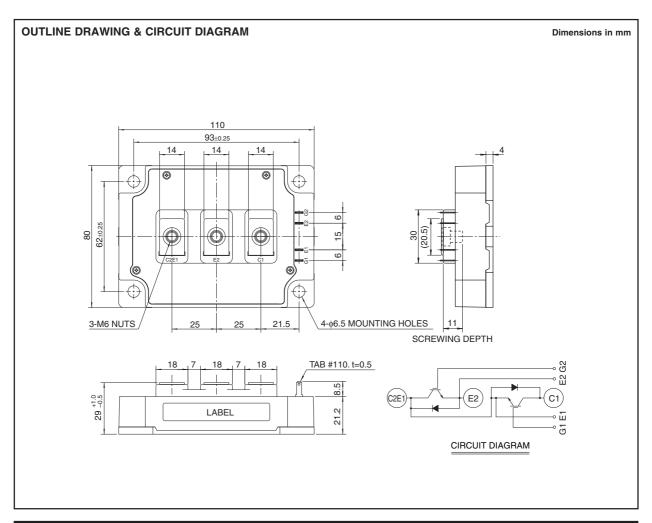
CM600DY-24A

HIGH POWER SWITCHING USE



APPLICATION

AC drive inverters & Servo controls, etc







HIGH POWER SWITCHING USE

ABSOLUTE MAXIMUM RATINGS (Tj = 25°C, unless otherwise specified)

Symbol	Parameter	Conditions		Ratings	Unit	
VCES	Collector-emitter voltage	G-E Short		1200	V	
VGES	Gate-emitter voltage	C-E Short		±20	V	
Ic	Collector current	DC, $Tc = 78^{\circ}C^{*1}$		600		
Ісм	Collector current	Pulse (Not	te 2)	1200	_ A	
IE (Note 1)	Consiste a consumer			600	^	
IEM (Note 1)	Emitter current	Pulse (Not	te 2)	1200	A	
PC (Note 3)	Maximum collector dissipation	$Tc = 25^{\circ}C^{*1}$		3670	W	
Tj	Junction temperature			− 40 ~ +150	°C	
Tstg	Storage temperature			− 40 ~ +125	°C	
Viso	Isolation voltage	Terminals to base plate, f = 60Hz, AC 1 minute		2500	Vrms	
_	Tavava atvanath	Main terminals M6 screw		3.5 ~ 4.5	N • m	
_	Torque strength	Mounting M6 screw		3.5 ~ 4.5		
_	Weight	Typical value		580	g	

ELECTRICAL CHARACTERISTICS (Tj = 25°C, unless otherwise specified)

Cumple al	Parameter	Test conditions		Limits			1.1
Symbol	Parameter			Min.	Тур.	Max.	Unit
ICES	Collector cutoff current	VCE = VCES, VGE = 0V			_	1	mA
VGE(th)	Gate-emitter threshold voltage	IC = 60mA, VCE = 10V		6	7	8	٧
IGES	Gate leakage current	\pm VGE = VGES, VCE = 0V		_	_	0.5	μΑ
Va=()	Collector-emitter saturation voltage	IC = 600A, VGE = 15V	Tj = 25°C	_	2.1	3.0	٧
VCE(sat)			Tj = 125°C	_	2.4	_	
Cies	Input capacitance	VCE = 10V VGE = 0V			_	94	nF
Coes	Output capacitance			_	_	8	
Cres	Reverse transfer capacitance				_	1.8	
QG	Total gate charge	Vcc = 600V, Ic = 600A, VGE = 15V		_	2700	_	nC
td(on)	Turn-on delay time				_	660	
tr	Turn-on rise time	Vcc = 600V, Ic = 600A VGE = ± 15 V RG = 0.52 Ω , Inductive load IE = 600A		_	_	190	ns
td(off)	Turn-off delay time			_	_	700	
tf	Turn-off fall time				_	350	
trr (Note 1)	Reverse recovery time			_	_	250	ns
Qrr (Note 1)	Reverse recovery charge				19	_	μC
VEC(Note 1)	Emitter-collector voltage	IE = 600A, VGE = 0V		_	_	3.8	V
Rth(j-c)Q	Thermal resistance	IGBT part (1/2 module)*1			_	0.034	K/W
Rth(j-c)R	Thermal resistance	FWDi part (1/2 module)*1		_	_	0.062	
Rth(c-f)	Contact thermal resistance	Case to heat sink, Thermal compound Applied (1/2 module)*2		_	0.018	_	
Rg	External gate resistance			0.52	_	7.8	Ω

^{*1 :} Case temperature (Tc), heat sink temperature (Tf) measured point is just under the chips. *2 : Typical value is measured by using thermally conductive grease of λ = 0.9[W/(m • K)].



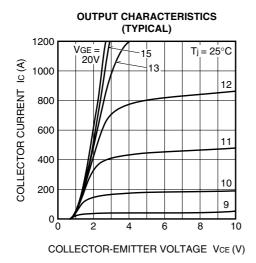
Note 1. IE, VEC, trr & Qrr represent characteristics of the anti-parallel, emitter-collector free-wheel diode (FWDi).

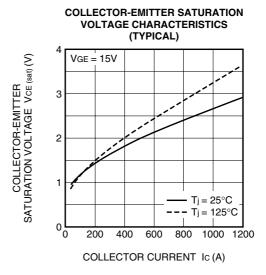
^{2.} Pulse width and repetition rate should be such that the device junction temperature (Tj) does not exceed T_{jmax} rating.

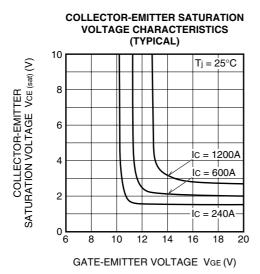
3. Junction temperature (Tj) should not increase beyond 150°C.

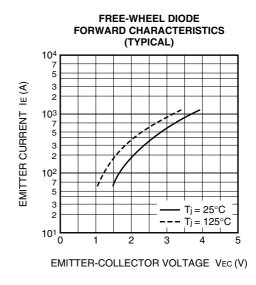
HIGH POWER SWITCHING USE

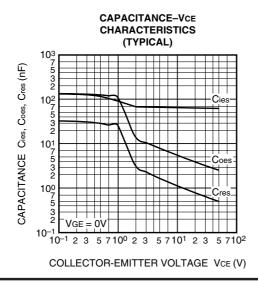
PERFORMANCE CURVES

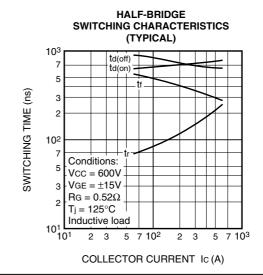














Feb. 2009

HIGH POWER SWITCHING USE

OF FREE-WHEEL DIODE (TYPICAL) Irr (A) 10³ trr (ns) REVERSE RECOVERY CURRENT 5 REVERSE RECOVERY TIME 3 2 102 tr 7 Conditions: 5 Vcc = 600V3 $VGE = \pm 15V$

2

101 L 101

2

3 5

REVERSE RECOVERY CHARACTERISTICS

EMITTER CURRENT IE (A)

7 10²

 $RG = 0.52\Omega$

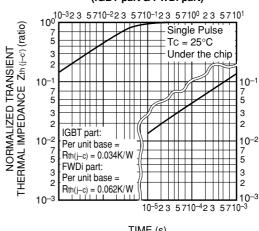
Inductive load

5 7 10³

T_i = 25°C

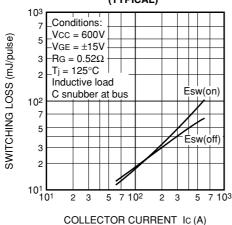
3

TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (IGBT part & FWDi part)

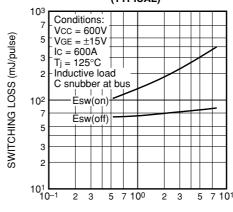


TIME (s)

SWITCHING LOSS vs. **COLLECTOR CURRENT** (TYPICAL)

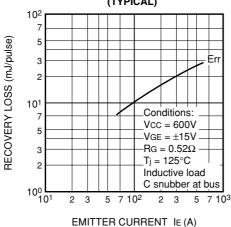


SWITCHING LOSS vs. **GATE RESISTANCE** (TYPICAL)

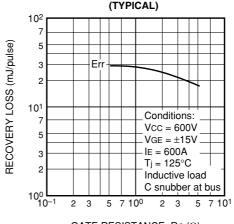


GATE RESISTANCE RG (Ω)

RECOVERY LOSS vs. IE (TYPICAL) 102



RECOVERY LOSS vs. **GATE RESISTANCE** (TYPICAL)



GATE RESISTANCE RG (Ω)



HIGH POWER SWITCHING USE



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